XA-9485A
PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Masaya MURANAKA et al.

Appln. No.:

Filed: HEREWITH

For: METHOD OF DECIDING ERROR RATE AND SEMICONDUCTOR INTEGRATED CIRCUIT DEVICE

* * *

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Applicants wish to make of record the documents cited in prior Application No. 09/875,961 filed June 8, 2001, whether cited by Applicants or by the Patent Office. The documents are listed on the attached Form PTO-1449.

Respectfully submitted,

MWS:adc

By: _____
Mitchell W. Shapiro
Reg. No. 31,568

Miles & Stockbridge P.C.
1751 Pinnacle Drive
Suite 500
McLean, Virginia 22102-3833
(703) 903-9000

March 25, 2004

FORM PTO-1449 LIST OF DOCUMENTS CITED BY APPLICANT	Atty. Docket No. XA-9485A	Appln. No.
	Applicant Masaya MURANAKA et al.	
	Filing Date HEREWITH	Group

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	AA	6,560,725 B1	05/2003	Longwell et al.	714	54	
	AB	6,065,146 A	05/2000	Bosshart, Patrick	714	754	
	AC	6,236,602 B1	05/2001	Patti, Robert	365	201	
	AD	4,794,597 A	12/1988	Ooba et al.	714	703	
	AE	4,758,992 A	07/1988	Taguchi, Masao	365	222	
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
	AJ	11-213659	08/06/99	Japan			Abstract
	AK	07-262794	10/13/95	Japan			Abstract
	AL	11-007760 A	01/12/99	Japan			Abstract
	AM						
	AN						
	AO						

OTHER (including author, title, date, pertinent pages, etc.)

	AP	Mano, T.; Yamada, J.; Inoue, J.; Nakajima, S.; Circuit Techniques For A VLSI Memory, IEEE Journal of Solid-State Circuits, Volume: 18 Issue: 5, October 1983, Pages 463-470
	AQ	
	AR	

Examiner	Date Considered

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.